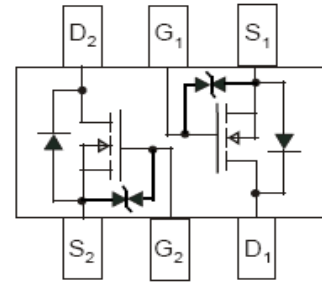
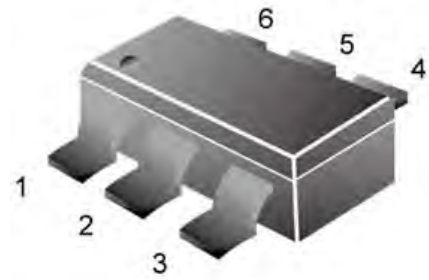


## Dual N-Channel MOSFET

### DUAL N-CHANNEL ENHANCEMENT MODE FIELD EFFECT TRANSISTOR

- Low On-Resistance
- Fast Switching Speed
- Low-voltage drive
- Easily designed drive circuits
- ESD Protected: 1000V



### Maximum Ratings and electrical characteristic

Ratings at 25°C ambient temperature unless otherwise specified

Symbol	PARAMETER	Typical	Units
$V_{DSS}$	Drain-Source Voltage	60	V
$V_{GSS}$	Gate-Source Voltage - Continuous	$\pm 20$	V
$I_D$	Drain Current - Continuous	115	mA
	Drain Current - Pulsed*1	800	
$I_{DR}$	Reverse drain Current - Continuous	115	mA
	Reverse drain Current - Pulsed*1	800	
$P_D$	Total Power Dissipation*2	225	mW
$T_{ch}$	Channel temperature	150	°C
$T_J, T_{STG}$	Operating and Storage Temperature Range	-55 to +150	°C

\*1  $P_w \leq 10 \mu s$ , Duty cycle  $\leq 1\%$

\*2 When mounted on a 1\*0.75\*0.062 inch glass epoxy board



## Dual N-Channel MOSFET

### Maximum ratings and electrical characteristic

Ratings at 25°C ambient temperature unless otherwise specified

Symbol	Ratings	Test Conditions	Min	Typ	Max	Units
<b>OFF CHARACTERISTICS</b>						
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=10\mu A$	60	-	-	V
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS}=60V, V_{GS}=0V$	-	-	1.0	$\mu A$
$I_{GSS}$	Gate-source Leakage	$V_{DS}=0V, V_{GS}=\pm 20V$	-	-	$\pm 10$	$\mu A$
<b>ON CHARACTERISTIC</b>						
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=10V, I_D=1mA$	1.0	-	2.0	V
$R_{DS(ON)}$	Static Drain-Source On-Resistance	$V_{GS}=10V, I_D=0.5A$	-	-	7.5	$\Omega$
		$V_{GS}=5V, I_D=0.05A$	-	-	7.5	
$G_{FS}$	Forward Trans-conductance*	$V_{DS}=10V, I_D=0.2A$	80	-	-	mS
<b>DYNAMIC CHARACTERISTICS</b>						
$C_{ISS}$	Input Capacitance	$V_{DS}=25V, V_{GS}=0V,$ $F=1.0MHz$	-	25	50	pF
$C_{OSS}$	Output Capacitance		-	10	25	
$C_{RSS}$	Reverse Transfer Capacitance		-	3.0	5.0	
<b>SWITCHING CHARACTERISTICS</b>						
$TD_{(ON)}$	Turn-On Dealy Time*	$V_{DD}=30V, I_D=0.2A,$ $V_{GS}=10V, RL=150\Omega, RG=10\Omega$	-	12	20	nS
$TD_{(OFF)}$	Turn-Off Delay Time*		-	20	30	

\*  $P_w \leq 300 \mu s$ , Duty cycle  $\leq 1\%$



### TYPICAL ELECTRICAL CHARACTERISTICS

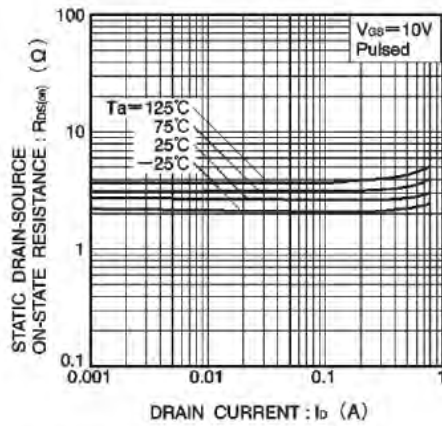


Fig.1 Static drain-source on-state resistance vs. drain current ( I )

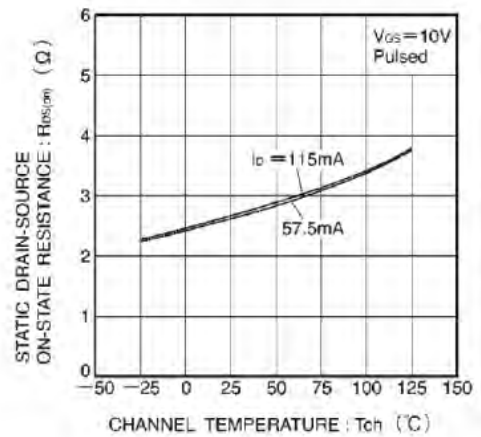


Fig.4 Static drain-source on-state resistance vs. channel temperature

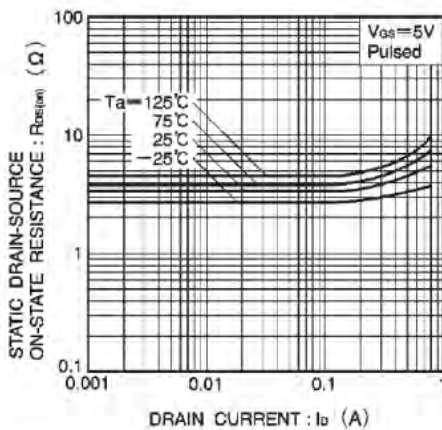


Fig.2 Static drain-source on-state resistance vs. drain current ( II )

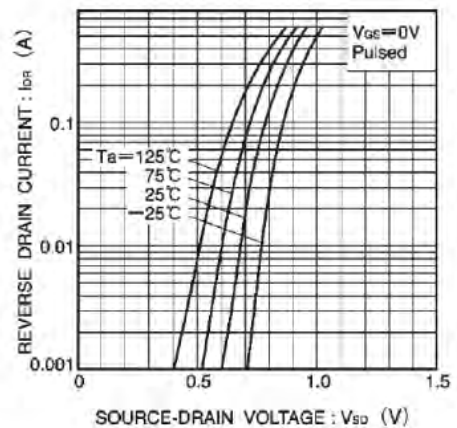


Fig.5 Reverse drain current vs. source-drain voltage ( I )

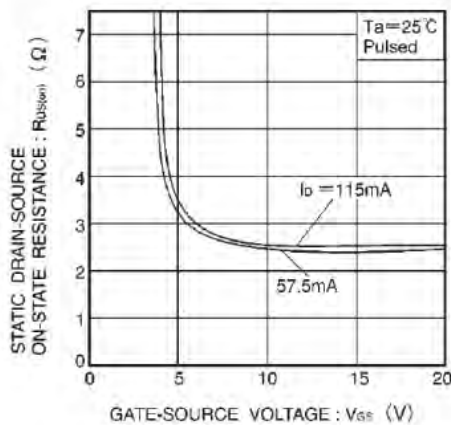


Fig.3 Static drain-source on-state resistance vs. gate-source voltage

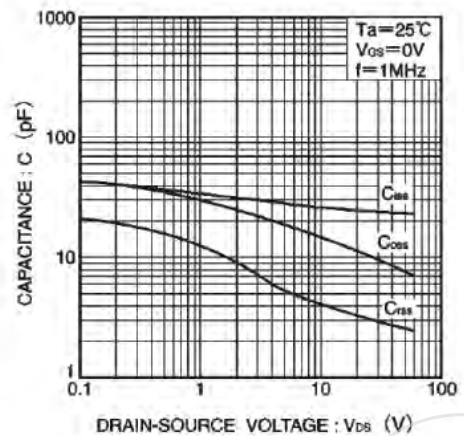
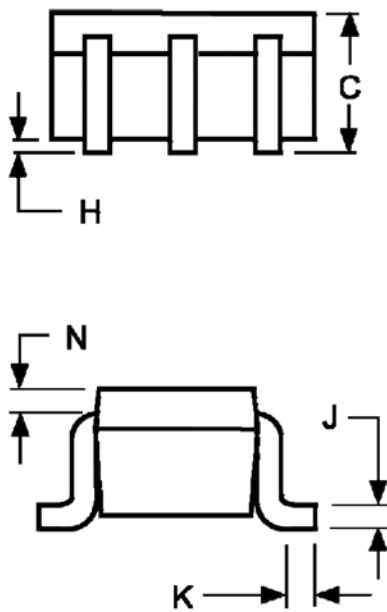
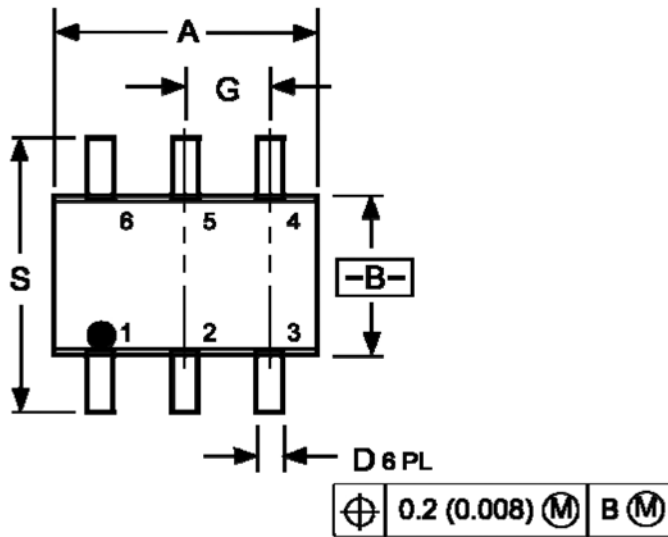


Fig.6 Typical capacitance vs. drain-source voltage



DIM	INCHES		MILLMETERS	
	MIN	MAX	MIN	MAX
A	0.071	0.087	1.80	2.20
B	0.045	0.053	1.15	1.35
C	0.031	0.043	0.80	1.10
D	0.004	0.012	0.10	0.30
G	0.026 BSC		0.65 BSC	
H	---	0.004	---	0.10
J	0.004	0.010	0.10	0.25
K	0.004	0.012	0.10	0.30
N	0.008 REF		0.20 REF	
S	0.079	0.087	2.00	2.20

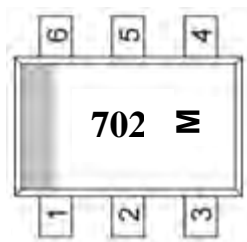


## Dual N-Channel MOSFET

Device name:ME2N7002D1KW-G

Package:SOT-363

Marking Code:



**702: Device Marking Code**

**M: Date code**

### MONTH CODE

#### ODD YEARS(2007,2009)

<b>Jan</b>	1
<b>Feb</b>	2
<b>Mar</b>	3
<b>Apr</b>	4
<b>May</b>	5
<b>Jun</b>	6
<b>Jul</b>	7
<b>Aug</b>	8
<b>Sep</b>	9
<b>Oct</b>	T
<b>Nov</b>	V
<b>Dec</b>	C

#### EVEN YEARS(2006,2008)

<b>Jan</b>	E
<b>Feb</b>	F
<b>Mar</b>	H
<b>Apr</b>	J
<b>May</b>	K
<b>Jun</b>	L
<b>Jul</b>	N
<b>Aug</b>	P
<b>Sep</b>	U
<b>Oct</b>	X
<b>Nov</b>	Y
<b>Dec</b>	Z

